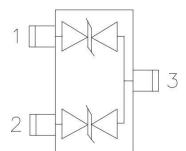








# **Pin Configuration**



# **Features**

- Ultra low leakage: nA level
- Operating voltage: 24V
- Low clamping voltage
- Complies with following standards:
  - IEC 61000-4-2 (ESD) immunity test
    Air discharge: ±30kV
    Contact discharge: ±30kV
    - IEC61000-4-4 (EFT) 40A (5/50ns)
  - IEC61000-4-5 (Lightning) 5A (8/20µs)
- RoHS Compliant
- AEC-Q101 Compliant

# **Applications**

- USB 2.0 power and data line
- Set-top box and digital TV
- Digital video interface (DVI)
- Notebook Computers
- SIM Ports
- 10/100 Ethernet

# **Mechanical Characteristics**

- Package: SOT-23
- Lead Finish: Lead Free
- UL Flammability Classification Rating 94V-0
- Quantity Per Reel:3,000pcs
- Reel Size:7inch

# Absolute Maximum Ratings(Tamb=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit	
Peak Pulse Power (8/20µs)	Ррр	300	W	
ESD per IEC 61000-4-2 (Air)		±30	Κv	
ESD per IEC 61000-4-2 (Contact)	V <sub>ESD</sub>	$\pm 30$		
Operating Temperature Range	TJ	-55 to +125	°C	
Storage Temperature Range	T <sub>STJ</sub>	-55 to +150	°C	





# Electrical Characteristics(TA=25°C unless otherwise specified)

P/N	V <sub>RWM</sub> (V)	Vbr (V)	l⊤ (mA)	Vc @1A	(Max)	′c (@A)	l <sub>ℝ</sub> μΑ (Max)	C (Pf) (Typ.)
PESD1CAN	24	27	1	40	45	5	0.2	25

# **Characteristic Curves**

#### Fig1. 8/20 $\mu$ sPulse Waveform 120 100% TEST Peak Value IPP tr WAVEFORM PARAMETERS Percent of Peak Pulse Current % 90% 100 PP - Peak Pulse Current - % of PP tr=8µs 80 t₀=20µs 60 40 td=t IPP/2 10% 20 Time (ns) tr = 0.7~1ns 0 30ns – -0 5 10 15 20 25 30 60ns t - Time (Ls)



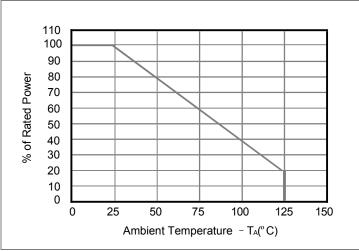
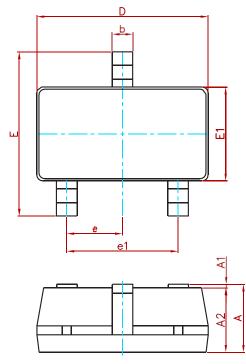


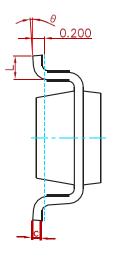
Fig2. ESD Pulse Waveform (according to IEC 61000-4-2)





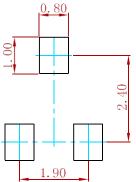
### PACKAGE MECHANICAL DATA





Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
0	0°	8°	0°	8°	

### Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
 General tolerance:± 0.05mm.
 The pad layout is for reference purposes only.

### **REEL SPECIFICATION**

P/N	PKG	QTY
PESD1CAN	SOT-23	3000



# PESD1CAN HF Semiconductor Compiance

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